	Application No.	Applicant(s)
Notice of Allowability Ex	09/986,299	HIROI ET AL.
	Examiner	Art Unit
	John D. Strong	2624
	John B. Strege	2624
The MAILING DATE of this communication apperature All claims being allowable, PROSECUTION ON THE MERITS IS therewith (or previously mailed), a Notice of Allowance (PTOL-85) NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT Report of the Office or upon petition by the applicant. See 37 CFR 1.313	(OR REMAINS) CLOSED in to or other appropriate communi GHTS. This application is sub	nis application. If not included cation will be mailed in due course. THIS
1. This communication is responsive to the amendment filed 4	<u>4/13/06</u> .	
2. The allowed claim(s) is/are 28,29,31,32,34 and 37-46.		
3. Acknowledgment is made of a claim for foreign priority una) All b) Some* c) None of the:	der 35 U.S.C. § 119(a)-(d) or	(f) .
 Certified copies of the priority documents have 	been received.	
Certified copies of the priority documents have	been received in Application	No
Copies of the certified copies of the priority doc	cuments have been received in	n this national stage application from the
International Bureau (PCT Rule 17.2(a)).		
* Certified copies not received:		
Applicant has THREE MONTHS FROM THE "MAILING DATE" of noted below. Failure to timely comply will result in ABANDONM THIS THREE-MONTH PERIOD IS NOT EXTENDABLE.		reply complying with the requirements
4. A SUBSTITUTE OATH OR DECLARATION must be submit INFORMAL PATENT APPLICATION (PTO-152) which give		
5. CORRECTED DRAWINGS (as "replacement sheets") must	t be submitted.	
(a) ☐ including changes required by the Notice of Draftsperso	on's Patent Drawing Review (PTO-948) attached
1) ☐ hereto or 2) ☐ to Paper No./Mail Date		
(b) ☐ including changes required by the attached Examiner's Paper No./Mail Date	Amendment / Comment or in	the Office action of
Identifying indicia such as the application number (see 37 CFR 1.6 each sheet. Replacement sheet(s) should be labeled as such in the		
6. DEPOSIT OF and/or INFORMATION about the depose attached Examiner's comment regarding REQUIREMENT F		
Attachment(s) 1. ☐ Notice of References Cited (PTO-892)	5. ☐ Notice of Infor	mal Patent Application (PTO-152)
2. Notice of Draftperson's Patent Drawing Review (PTO-948)	6. Interview Sum	mary (PTO-413),
3. ☐ Information Disclosure Statements (PTO-1449 or PTO/SB/08	Paper No./Ma B), 7. ⊠ Examiner's Ar	ail Date nendment/Comment
Paper No./Mail Date	8. ⊠ Examiner's St	atement of Reasons for Allowance
of Biological Material	9. Other	
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EXAMINER'S AMENDMENT

1. An examiner's amendment to the record appears below. Should the changes and/or additions be unacceptable to applicant, an amendment may be filed as provided by 37 CFR 1.312. To ensure consideration of such an amendment, it MUST be submitted no later than the payment of the issue fee.

Authorization for this examiner's amendment was given in a telephone interview with Melvin Kraus #22,466 on 6/23/06.

The application has been amended as follows:

In **Claim 34**, replace "corrected" on line 28 (2nd line from the bottom) with --defined--.

The amendment was made to give the limitation antecedent basis.

Response to Amendment

2. The amendment received 4/13/06 has been entered in full.

Response to Arguments

3. Applicant's arguments, see pages 10-13, filed 4/13/06, with respect to claims 28-29, 31-32,34,37-42 have been fully considered and are persuasive. The rejection of the claims has been withdrawn.

Allowable Subject Matter

- 4. Claims 28-29,31-32,34, and 37-46 are allowed.
- 5. The following is an examiner's statement of reasons for allowance: None of the prior art of record discloses a pattern inspection method comprising: conditioning for

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setting up a mask region in a specimen to be inspected; and inspecting for detecting defects on the specimen and outputting information of defects which are detected in areas other than said mask region on said specimen wherein a mask region is defined in a test inspection area on a display screen in which the detected defects are displayed in a map format; and saving a data of said defined mask region in a recipe to be used in subsequent iterations of the inspecting operation. Thus claims 28,31,34, and 38 are allowable over the prior art. Furthermore dependent claims 29,32,37, and 39-46 are allowable for the same reason given for the independent claims.

Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

Contact Information

Any inquiry concerning this communication or earlier communications from the examiner should be directed to John B. Strege whose telephone number is (571) 272-7457. The examiner can normally be reached on Monday-Friday between the hours of 8-5.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Bhavesh Mehta can be reached on (571) 272-7453. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free). If you would like assistance from a USPTO Customer Service Representative or access to the automated information system, call 800-786-9199 (IN USA OR CANADA) or 571-272-1000.

JS

ANDREW W. JOHNS